

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SMITH ET AL.	
		Examiner Richard Woo	Art Unit 3629	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,081,789	06-2000	Purcell, Daniel S.	705/37
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	WO 01/13261 A1	02-2001	PCT	Juedes et al.	-/-
O	JP 2001297270 A	10-2001	Japan	Hitachi Ltd.	-/-
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
U	James A. Senn, WISs at Federal Express, 07-1998, Communications of the ACM, vol. 41, No. 7, 2 pages.	
V		
W		
X		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.